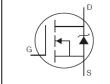


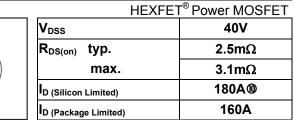
Features

- Logic Level
- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *

Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.

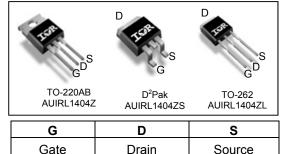




AUIRL1404Z

AUIRL1404ZS

AUIRL1404ZL



Base part number	Dookogo Turo	Standard Pack	Υ.	Orderable Part Number	
	Package Type	Form	Quantity	Orderable Part Nulliber	
AUIRL1404Z	TO-220	Tube	50	AUIRL1404Z	
AUIRL1404ZL	TO-262	Tube	50	AUIRL1404ZL	
	D ² -Pak	Tube	50	AUIRL1404ZS	
AUIRL1404ZS	D -Pak	Tape and Reel Left	800	AUIRL1404ZSTRL	

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	180®	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	130	•
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Package Limited)	160	A
I _{DM}	Pulsed Drain Current ①	790	
P _D @T _C = 25°C	Maximum Power Dissipation	200	W
	Linear Derating Factor	1.3	W/°C
V _{GS}	Gate-to-Source Voltage	± 16	V
E _{AS}	EASSingle Pulse Avalanche Energy (Thermally Limited) (2)190		
E _{AS} (tested)	Single Pulse Avalanche Energy Tested Value 6	490	mJ
I _{AR}	Avalanche Current ①	See Fig.15,16, 12a, 12b	А
E _{AR}	Repetitive Avalanche Energy S		mJ
TJ	Operating Junction and	-55 to + 175	
Г _{STG} Storage Temperature Range			°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)	

Thermal Resistance Symbol Parameter Units Max. Тур. Junction-to-Case 0.759 $R_{\theta JC}$ Case-to-Sink, Flat, Greased Surface ⑦ 0.50 R_{0CS} °C/W Junction-to-Ambient 🗇 62 $R_{\theta JA}$ Junction-to-Ambient (PCB Mount, steady state) ⑦ 40 R_{0JA}

HEXFET® is a registered trademark of Infineon.

*Qualification standards can be found at www.infineon.com



Static @ T _J =	25°C (unless otherwise specified)					
	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	40			V	V _{GS} = 0V, I _D = 250μA
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.034		V/°C	Reference to 25°C, $I_D = 1mA$
			2.5	3.1		V _{GS} = 10V, I _D = 75A ③**
R _{DS(on)}	Static Drain-to-Source On-Resistance			4.7	mΩ	V _{GS} = 5.0V, I _D = 40A ③
				5.9		VGS = 4.5V, ID = 40A ③
V _{GS(th)}	Gate Threshold Voltage	1.4		2.7	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$
gfs	Forward Trans conductance	120			S	V _{DS} = 10V, I _D = 75A**
I _{DSS}	Drain-to-Source Leakage Current		<u></u>	20 250	μA	$V_{DS} = 40V, V_{GS} = 0V$ $V_{DS} = 40V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			200		V _{GS} = 16V
	Gate-to-Source Reverse Leakage			-200	nA	V _{GS} = -16V
Dynamic Ele	ctrical Characteristics @ T」 = 25°C (unless ot	herwis	se spec	cified)		
Q _g	Total Gate Charge		75	110		I _D = 75A**
Q _{gs}	Gate-to-Source Charge		28		nC	$V_{\rm DS} = 32V$
Q _{gd}	Gate-to-Drain Charge		40			V _{GS} = 5.0V3
t _{d(on)}	Turn-On Delay Time		19			V _{DD} = 20V
t _r	Rise Time		180			I _D = 75A**
t _{d(off)}	Turn-Off Delay Time		30		ns	R _G = 4.0Ω,
t _f	Fall Time		49			V _{GS} = 5.0V ③
L _D	Internal Drain Inductance		4.5			Between lead, 6mm (0.25in.)
L _S	Internal Source Inductance		7.5		nH	from package
C _{iss}	Input Capacitance		5080			V _{GS} = 0V
C _{oss}	Output Capacitance		970			$V_{DS} = 25V$
C _{rss}	Reverse Transfer Capacitance		570			f = 1.0MHz
C _{oss}	Output Capacitance		3310		pF	$V_{GS} = 0V, V_{DS} = 1.0V f = 1.0MHz$
C _{oss}	Output Capacitance		870			$V_{GS} = 0V, V_{DS} = 32V f = 1.0MHz$
C _{oss eff.}	Effective Output Capacitance		1280		-	$V_{GS} = 0V, V_{DS} = 0V \text{ to } 32V $
Diode Charac						
	Parameter	Min.	Typ.	Max.	Units	Conditions
	Continuous Source Current					MOSFET symbol
I _S	(Body Diode)			180	^	showing the
	Pulsed Source Current			790	A	integral reverse
I _{SM}	(Body Diode) ①			190		p-n junction diode.
V _{SD}	Diode Forward Voltage			1.3	V	T _J = 25°C,I _S = 75A**,V _{GS} = 0V ③
t _{rr}	Reverse Recovery Time		26	39	ns	T _J = 25°C ,I _F = 75A** , V _{DD} = 20V
Q _{rr}	Reverse Recovery Charge		18	27	nC	di/dt = 100A/µs
t _{on}	Forward Turn-On Time	Intrins	ic turn-o	on time	is neglio	gible (turn-on is dominated by $L_{S}+L_{D}$)
L						

Notes:

① Repetitive rating; pulse width limited by max. junction temperature. (See fig.11)

Limited by T_{Jmax}, starting T_J = 25°C, L = 0.066mH, R_G = 25Ω, I_{AS} = 75A, V_{GS} =10V. Part not recommended for use above this value.
 Pulse width ≤ 1.0ms; duty cycle ≤ 2%.

④ C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.

S Limited by T_{Jmax}, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.

© This value determined from sample failure population 100% tested to this value in production.

⑦ This is only applied to TO-220AB package.

When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994

TO-220Pak device will have an Rth value of 0.65°C/W.

© Calculated continuous current based on maximum allowable junction temperature. Bond wire current limit is 160A. Note that current I imitations arising from heating of the device leads may occur with some lead mounting arrangements.

** All AC and DC test conditions based on former package limited current of 75A.



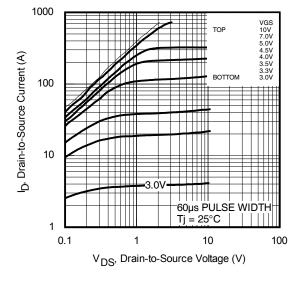


Fig. 1 Typical Output Characteristics

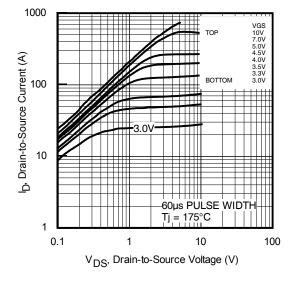


Fig. 2 Typical Output Characteristics

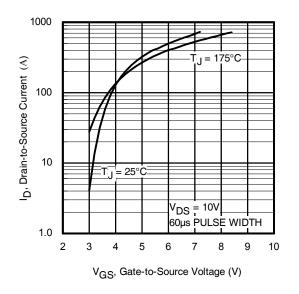


Fig. 3 Typical Transfer Characteristics

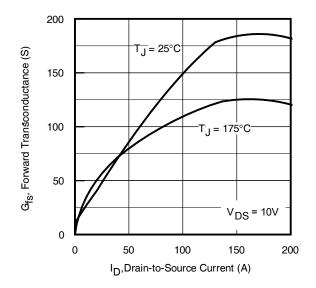


Fig. 4 Typical Forward Transconductance vs. Drain Current



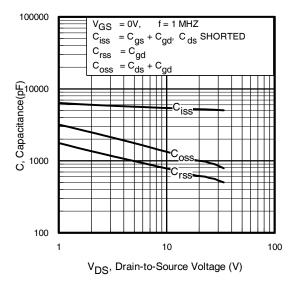


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

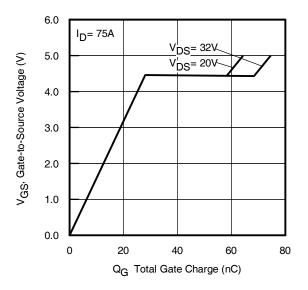


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

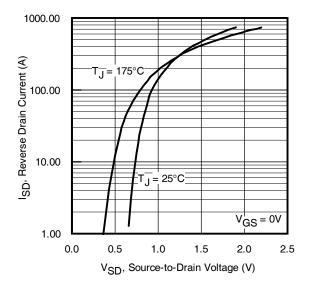


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

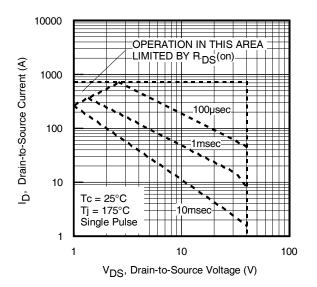


Fig 8. Maximum Safe Operating Area



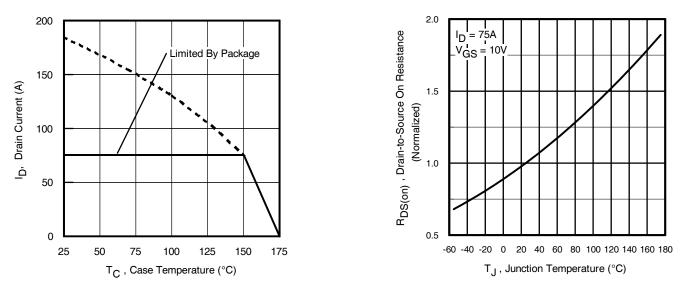
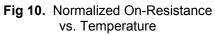


Fig 9. Maximum Drain Current vs. Case Temperature



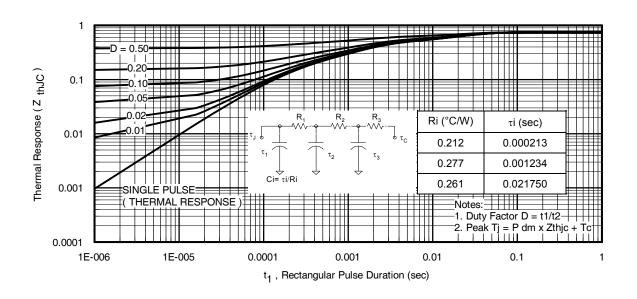


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

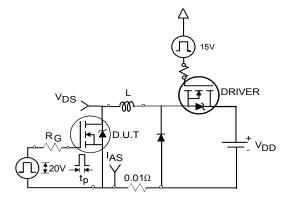


Fig 12a. Unclamped Inductive Test Circuit

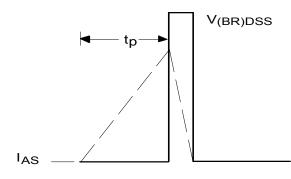


Fig 12b. Unclamped Inductive Waveforms

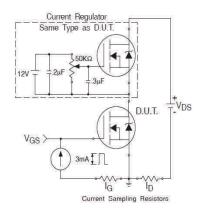


Fig 13a. Gate Charge Test Circuit

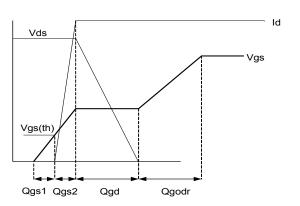


Fig 13b. Gate Charge Waveform

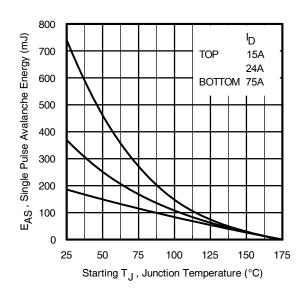


Fig 12c. Maximum Avalanche Energy vs. Drain Current

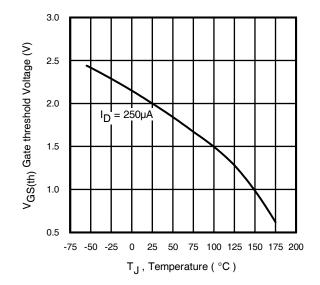


Fig 14. Threshold Voltage vs. Temperature



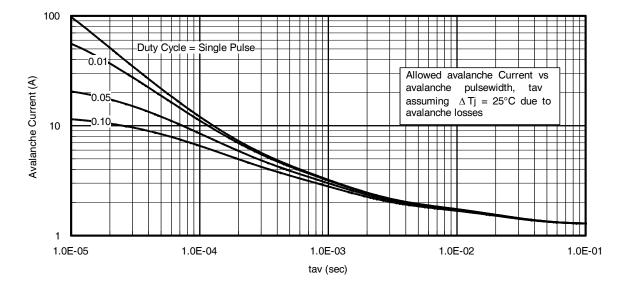


Fig 15. Avalanche Current vs. Pulse width

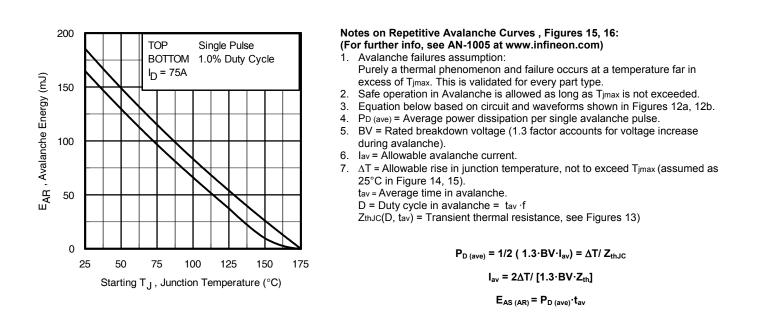


Fig 16. Maximum Avalanche Energy vs. Temperature

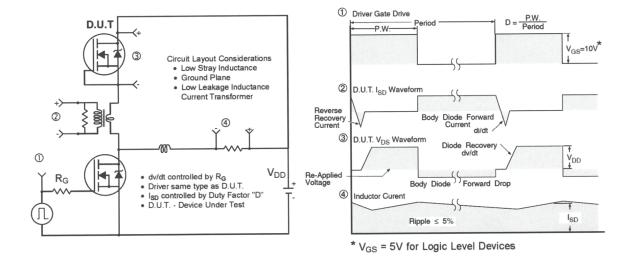


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

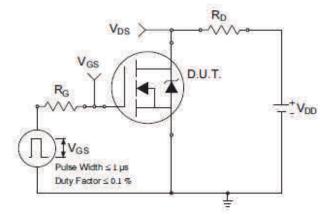


Fig 18a. Switching Time Test Circuit

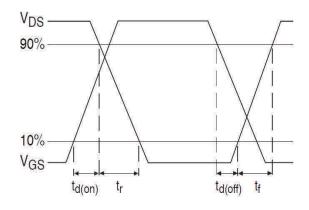
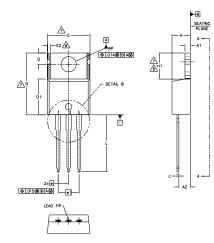


Fig 18b. Switching Time Waveforms



TO-220AB Package Outline (Dimensions are shown in millimeters (inches))





- DIMENSIONING AND TOLERANCING AS PER ASME Y14.5 M- 1994. 1.-
- DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS]. 2.-
- LEAD DIMENSION AND FINISH UNCONTROLLED IN LI 3.-
- DIMENSION D, D1 & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE 4.-MEASURED AT THE OUTERWOST EXTREMES OF THE PLASTIC BODY.
- DIMENSION 61, 63 & c1 APPLY TO BASE METAL ONLY.
- <u>/5.</u>_ 6.-CONTROLLING DIMENSION : INCHES.
- THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E,H1,D2 & E1 7.-
- DIMENSION E2 X H1 DEFINE A ZONE WHERE STAMPING AND SINGULATION IRREGULARITIES ARE ALLOWED. 8.–
- UTUINE CONFORMS TO JEDEC TO -220, EXCEPT A2 (max.) AND D2 (min.) WHERE DIMENSIONS ARE DERIVED FROM THE ACTUAL PACKAGE OUTLINE. 9.-

	DIMENSIONS				
SYMBOL	MILLIMETERS		INC		
	Min.	MAX.	MIN.	MAX.	NOTES
A	3.56	4.83	.140	.190	
A1	1,14	1.40	.045	.055	
A2	2.03	2.92	.080	.115	
b	0.38	1.01	.015	.040	
b1	0.38	0.97	.015	.038	5
b2	1.14	1.78	.045	.070	
b3	1.14	1.73	.045	.068	5
с	0.36	0.61	.014	.024	
c1	0.36	0.56	.014	.022	5
D	14.22	16.51	.560	.650	4
D1	8.38	9.02	.330	.355	
D2	11.68	12.88	.460	.507	7
E	9.65	10.67	.380	.420	4,7
E1	6.86	8.89	.270	.350	7
E2	-	0.76	-	.030	8
e	2.54	BSC	.100	BSC	
e1	5.08 BSC		.200	BSC	
H1	5.84	6.86	.230	.270	7,8
L	12.70	14.73	.500	.580	
L1	3.56	4.06	.140	.160	3
øР	3.54	4.08	.139	.161	
Q	2.54	3.42	.100	.135	

LEAD ASSIGNMENTS

<u>HEXFET</u> 1.- GATE 2.- DRAIN 3.- SOURCE

IGBTs, CoPACK

1.- GATE 2.- COLLECTOR 3.- EMITTER

DIODES

1.- ANODE 2.- CATHODE 3.- ANODE

TO-220AB Part Marking Information

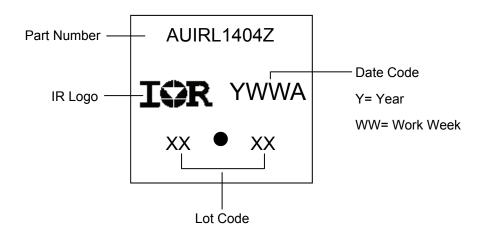
e1 A

VEW A-A

DETAIL B

-61,63-6

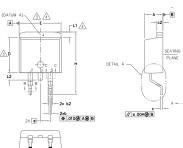
SECTION C-C & D-D



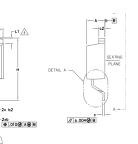
Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



D²Pak (TO-263AB) Package Outline (Dimensions are shown in millimeters (inches))



AD TIF





- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61, 63 AND c1 APPLY TO BASE METAL ONLY.

6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.

7. CONTROLLING DIMENSION: INCH.

8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

	PLATING BASE META
VEW A-A	ROTATED 90° CW SCALE 8:1

S Y M		DIMEN	SIONS		N
B O	MILLIM	ETERS	INC	O T E S	
L	MIN.	MAX.	MIN.	MAX.	L S
А	4.06	4.83	.160	.190	
A1	0.00	0.254	.000	.010	
Ь	0.51	0.99	.020	.039	
Ь1	0.51	0.89	.020	.035	5
b2	1.14	1.78	.045	.070	
b3	1.14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
с1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	_	.270	_	4
Е	9.65	10.67	.380	.420	3,4
E1	6.22	—	.245	—	4
е	2.54	BSC	.100	BSC	
Н	14.61	15.88	.575	.625	
L	1.78	2.79	.070	.110	
L1	_	1.68	-	.066	4
L2	_	1.78	-	.070	
L3	0.25	BSC	.010	BSC	

LEAD ASSIGNMENTS

HEXFET

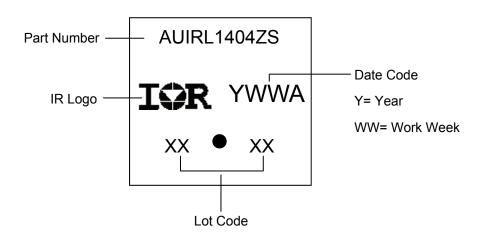
1.- GATE 2, 4.- DRAIN 3.- SOURCE

DIODES 1.- ANODE (TWO DIE) / OPEN (ONE DIE) 2, 4.- CATHODE 3.- ANODE

> IGBTS, COPACK 1.- GATE 2, 4.- COLLECTOR 3.- EMITTER



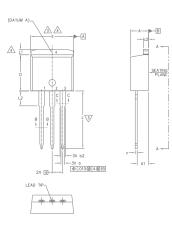
D²Pak (TO-263AB) Part Marking Information

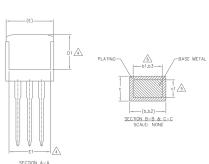


Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



TO-262 Package Outline (Dimensions are shown in millimeters (inches)





NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED $^{\circ}$ 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- 4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
- 5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.
- 6. CONTROLLING DIMENSION: INCH.
- 7.- OUTLINE CONFORM TO JEDEC TO-262 EXCEPT A1(max.), b(min.) AND D1(min.) WHERE DIMENSIONS DERIVED THE ACTUAL PACKAGE OUTLINE

LEAD ASSIGNMENTS

IGBT	s,	Со	PA	١C	<

- 1.- GATE 2.- COLLECTOR 3.- EMITTER
- 4.- COLLECTOR

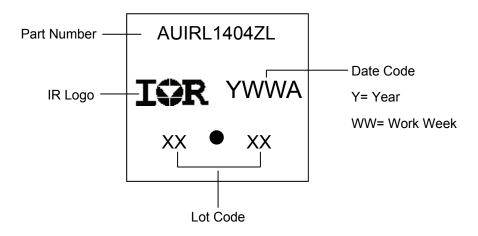
HEXFET DIODES

- 1.- ANODE (TWO DIE) / OPEN (ONE DIE) 1. - GATE
- 2.- DRAIN 3.- SOURCE 2, 4.- CATHODE 3.- ANODE
- 4.- DRAIN



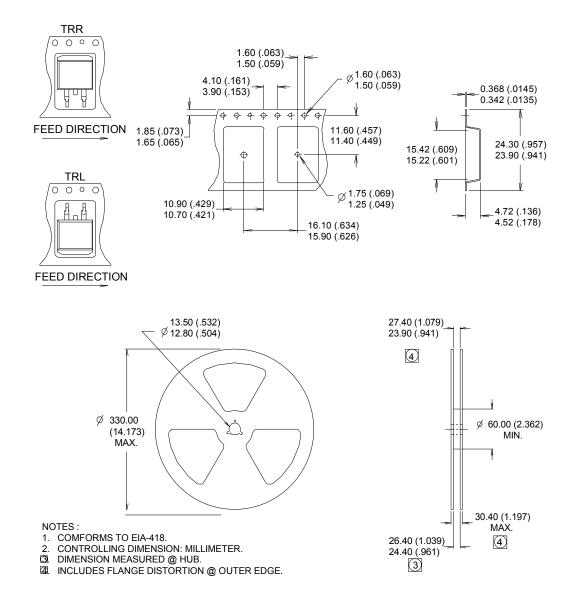
S Y DIMENSIONS N 0 M B O MILLIMETERS INCHES MIN. MAX MIN. MAX А 4.06 4.83 160 .190 A1 2.03 3.02 .080 .119 b 0.51 0.99 .039 0.51 .035 b1 0.89 5 1.78 1.14 045 b3 1.14 1.73 .045 .068 5 0.38 0.74 .015 .029 С с1 0.38 0.58 .015 .023 5 .045 c2 1.14 1.65 .065 D 8.38 9.65 .330 .380 3 D1 6.86 .270 4 Ε 9.65 10.67 .380 .420 3,4 E1 6.22 245 4 2.54 BSC е 13.46 14,10 555 L1 1.65 .065 4 3.56 3.71 .140 .146

TO-262 Part Marking Information



Note: For the most current drawing please refer to IR website at <u>http://www.irf.com/package/</u>

D²Pak (TO-263AB) Tape & Reel Information (Dimensions are shown in millimeters (inches))



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information

		Automotive (per AEC-Q101)				
			s part number(s) passed Automotive qualification. Infineon's onsumer qualification level is granted by extension of the higher I.			
		TO-220 Pak	N/A			
Moisture	Moisture Sensitivity Level		MSL1			
	Machine Model	Class M4 (+/- 425V) [†]				
		AEC-Q101-002				
	Human Dady Madal	Class H1C (+/- 2000V) [†]				
ESD	ESD Human Body Model		AEC-Q101-001			
	Charged Device Model		Class C5 (+/- 1125V) [†]			
			AEC-Q101-005			
RoHS Compliant			Yes			

Revision History

Date	Comments		
10/27/2015	Updated datasheet with corporate template		
10/27/2015	Corrected ordering table on page 1.		

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